

Wavelet Solution of The Inverse Source Problems

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Abstract - Generally, the inverse source problem is reduced into solving an ill-posed system of equations. This article proposes a novel approach for the inverse source problem employing the wavelet analysis. The wavelet analysis has two distinguished abilities; one is the image data compression ability and the other is the spectrum resolution ability of the wave forms. Key idea is that the system matrix of the inverse source problems is regarded as a two-dimensional image data. The two-dimensional wavelet transform is applied to this system matrix. Finally, we can obtain an approximate inverse matrix of the system. A simple example demonstrates the validity of our approach.

I. INTRODUCTION

Inverse problems are classified into two major categories, i.e. one is the inverse parameter problem which evaluates the medium parameters by applying the electromagnetic fields to a target region and measuring its response; the other is the inverse source problem which evaluates the electromagnetic field sources from the locally measured electromagnetic fields. Generally, most of the inverse problems are reduced into solving the ill-posed system of equations.

Previously, we have proposed a method of solving for the inverse problems, and successfully applied to the biomagnetic fields as well as the nondestructive testing in metallic materials [1,2].

In the present article, we propose a novel approach utilizing the wavelet analysis. The wavelet analysis has been studied for the image data compression and analyzing the spectrum of image in informatics [3-6]. The wavelet analysis has two distinguished abilities; one is the image data compression ability and the other is the spectrum resolution ability of the wave forms. Key idea of our approach is that the system matrix of the inverse problems is regarded as a two-dimensional image data. The system matrix transformed into the wavelet spectrum space is composed of the two representative spectrums; one group has the larger absolute value, the other has nearly zero value. After collecting the spectrums having larger absolute value and building up the square matrix, an inverse of the square matrix is evaluated. Combining this local inverse matrix with the zero rectangular matrix, we apply the inverse wavelet transform to the resultant matrix. Thus, we have succeeded in obtaining an approximate inverse matrix of the inverse source problems.

II. DISCRETE WAVELET TRANSFORM

A. One-dimensional wavelet transform

In the present article, we employ the Haar's analyzing wavelets [3]. Let us consider a following linear transformation.

$$\mathbf{X}' = \mathbf{C}\mathbf{X}, \quad (1)$$

where \mathbf{X} is a data vector with order n ; n must be a power of 2; and \mathbf{C} is

$$\mathbf{C} = \begin{bmatrix} c_0 & c_1 & 0 & 0 & \dots & 0 & 0 \\ c_1 & -c_0 & 0 & 0 & \dots & 0 & 0 \\ 0 & 0 & c_0 & c_1 & \dots & 0 & 0 \\ 0 & 0 & c_1 & -c_0 & \dots & 0 & 0 \\ \dots & \dots & \dots & \dots & \dots & \dots & \dots \\ 0 & 0 & 0 & 0 & \dots & c_0 & c_1 \\ 0 & 0 & 0 & 0 & \dots & c_1 & -c_0 \end{bmatrix}. \quad (2)$$

In equation (2), the first, third, fifth, and the other odd rows generate the components of data convolved with the coefficients c_0, c_1 . This corresponds to a weighted integral operation. On the other side, the even rows generate the components of data convolved with the coefficients $c_1, -c_0$. This corresponds to a weighted differential operation [3,5].

In order to carry out an inverse linear transformation, the coefficients c_0, c_1 should be determined by a relationship:

$$\mathbf{C}^T \mathbf{C} = \mathbf{I}, \quad (3)$$

where \mathbf{I} is a n -th order unit matrix and a superscript T refers to the transpose of matrix \mathbf{C} .

From equations (2) and (3), we have

$$c_0^2 + c_1^2 = 1. \quad (4)$$

Equation (4) has two unknowns c_0, c_1 , but we have only one equation. To determine the coefficients c_0, c_1 , generally, a following condition is considered:

$$c_0 - c_1 = 0. \tag{5}$$

From equation (4) and (5), we have

$$c_0 = \frac{1}{\sqrt{2}}, \quad c_1 = \frac{1}{\sqrt{2}}. \tag{6}$$

The pair of coefficient c_0, c_1 in (6) is the Haar's analyzing wavelets, which are the same as the Daubechies's second order analyzing wavelets [3,4].

For simplicity, let us consider a data vector X with order 8:

$$X = [x_1 \ x_2 \ x_3 \ x_4 \ x_5 \ x_6 \ x_7 \ x_8]^T. \tag{7}$$

Applying the transform matrix C_2 to (7)

$$X' = C_2 X = [s_1 \ d_1 \ s_2 \ d_2 \ s_3 \ d_3 \ s_4 \ d_4]^T. \tag{8}$$

The elements in vector X' is sorted by using following matrix:

$$P_2 = \begin{bmatrix} 1 & 0 & 0 & 0 & 0 & 0 & 0 & 0 \\ 0 & 0 & 1 & 0 & 0 & 0 & 0 & 0 \\ 0 & 0 & 0 & 0 & 1 & 0 & 0 & 0 \\ 0 & 0 & 0 & 0 & 0 & 0 & 1 & 0 \\ 0 & 1 & 0 & 0 & 0 & 0 & 0 & 0 \\ 0 & 0 & 0 & 1 & 0 & 0 & 0 & 0 \\ 0 & 0 & 0 & 0 & 0 & 1 & 0 & 0 \\ 0 & 0 & 0 & 0 & 0 & 0 & 0 & 1 \end{bmatrix}. \tag{9}$$

Thus, we have

$$P_2 X' = P_2 C_2 X = [s_1 \ s_2 \ s_3 \ s_4 \ d_1 \ d_2 \ d_3 \ d_4]^T. \tag{10}$$

Further transformation to the elements s_1, s_2, s_3, s_4 in (10) yields

$$W^2 X = [S_1 \ S_2 \ D_1 \ D_2 \ d_1 \ d_2 \ d_3 \ d_4]^T. \tag{11}$$

Similar transformation to S_1, S_2, D_1, D_2 in (11) yields

$$W^3 X = [S_1 \ D_1 \ D_2 \ d_1 \ d_2 \ d_3 \ d_4]^T. \tag{12}$$

The transformation matrix used in (11) and (12) are

$$W^{(2)} = (P_2' C_2') (P_2 C_2), \quad W^{(3)} = (P_3'' C_3'') (P_3' C_3') (P_3 C_3), \tag{13}$$

$$P_2' = \begin{bmatrix} P_2 & 0 \\ 0 & I_4 \end{bmatrix}, \quad C_2' = \begin{bmatrix} C_2 & 0 \\ 0 & I_4 \end{bmatrix}, \quad P_3'' = \begin{bmatrix} P_3 & 0 \\ 0 & I_4 \end{bmatrix}, \quad C_3'' = \begin{bmatrix} C_3 & 0 \\ 0 & I_4 \end{bmatrix}. \tag{14}$$

Equation (12) is the finally obtained wavelet spectrum. The elements S_1, D_1 in (12) are called the Mother Wavelet coefficients, and the others are called the wavelet coefficients at each level.

Inverse wavelet transform is carried out by

$$\begin{aligned} X &= [W^{(3)}]^T W^{(3)} X, \\ [W^{(3)}]^T &= [(P_3'' C_3'') (P_3' C_3') (P_3 C_3)]^T, \\ &= (P_3 C_3)^T (P_3' C_3')^T (P_3'' C_3'')^T, \\ &= C_3^T P_3^T (C_3')^T (P_3'')^T (C_3'')^T (P_3)^T. \end{aligned} \tag{15}$$

B. Two-dimensional wavelet transform

The discrete wavelet transform can be extended to the two dimensions [3]. Usually, two-dimensional wavelet transform is applied to a square matrix. In this article, two-dimensional wavelet transform is generalized to a rectangular matrix. The generalized two-dimensional wavelet transform is given by

$$M' = W_n M W_m^T, \tag{16}$$

where M' and M are the transformed (spectrum) matrix and original matrix with order n by m , respectively. W_n and W_m are the wavelet transform matrices with order n by n and m by m , respectively.

The inverse wavelet transform is carried out by the following equation:

$$M = W_n^T M' W_m. \tag{17}$$

III. THE INVERSE SOURCE PROBLEMS

A. Key idea

key idea is that the system matrix of the inverse source problems is regarded as one of the image data. The system matrix as an image data is transformed into a space of wavelet spectrum. The space of wavelet spectrum is composed of the two representative spectrums; one group has the larger absolute value, the other has nearly zero value. Collecting the spectrum having larger absolute value, we evaluate an inverse matrix of the system contracted to the non-singular size. Thus, the inverse wavelet transform yields an approximate inverse matrix of the system.

B. An example

An example of the inverse source problems is the estimation of current distribution on a film conductor from the locally measured magnetic fields. The estimation of

current distribution on a film is reduced into solving a following system equation

$$DX = Y, \quad (18a)$$

or

$$\begin{bmatrix} d_{11} & d_{12} & \cdots & \cdots & d_{1m} \\ d_{21} & d_{22} & \cdots & \cdots & d_{2m} \\ \vdots & \vdots & & \ddots & \vdots \\ d_{n1} & d_{n2} & \cdots & \cdots & d_{nm} \end{bmatrix} \begin{bmatrix} i_1 \\ i_2 \\ \vdots \\ i_m \end{bmatrix} = \begin{bmatrix} H_1 \\ H_2 \\ \vdots \\ H_n \end{bmatrix}, \quad m \gg n, \quad (18b)$$

where D, X and Y are a system matrix determined by the Ampere's law, a current distribution vector to be estimated, and a measured magnetic field vector, respectively. Because of $m \gg n$, it is difficult to determine the vector X . The numbering of the current sources and measured magnetic fields have an effect on the quality of the wavelet transform [3,4]. In this paper, we employed a natural numbering.

Figure 1(a) shows a schematic diagram of the example. Our problem is that the current distributions on the film conductor is estimated from the locally measured magnetic fields. Figures 1(b) and 1(c) show the exact current distribution, and the measured magnetic fields, respectively. Figures 1(d) shows the system matrix D determined by the Ampere's law.

C. Approximate inverse matrix

In order to solve the system equation (18), we apply the discrete wavelet transform to the system matrix. Namely, the system matrix D is transformed into the wavelet spectrum D' by

$$D' = W_n D W_m^T. \quad (19)$$

Secondly, we take a square matrix S around the Mother wavelet coefficient out of the entire wavelet spectrum D' . After we take an inverse of the square matrix S , this inverse matrix S^{-1} is embedded to the matrix Z with order m by n .

$$D'_{Appro}^{-1} = S^{-1} \rightarrow Z. \quad (20)$$

Equation (20) means that the inverse matrix S^{-1} is embedded at the top square region of Z .

Finally, an approximate inverse matrix D'_{Appro}^{-1} of the system is obtained by the two-dimensional inverse wavelet transform:

$$D_{Appro}^{-1} = W_n^T D'_{Appro}^{-1} W_m. \quad (21)$$

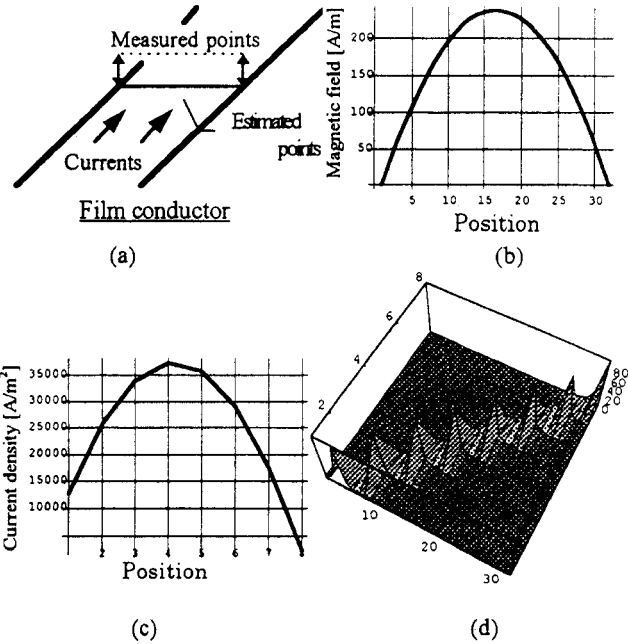


Fig.1. (a) A schematic diagram, (b) an exact current distribution, (c) measured magnetic fields, and (d) the system matrix D represented as an image data.

Figures 2(a) and 2(b) show a two-dimensional wavelet spectrum D' of figure 1(d) and an approximate inverse matrix D'_{Appro}^{-1} , respectively.

D. Validity of the approximate inverse matrix

Mathematical validity of the inverse matrix is generally carried out by means of the left- and right-inverse matrix checks. In this inverse source problem, the left-inverse matrix check $D'_{Appro}^{-1} D$ is not equivalent to the right-inverse matrix check DD'_{Appro}^{-1} , because the system matrix is a rectangular. When the left-inverse matrix check $D'_{Appro}^{-1} D$ becomes

$$D'_{Appro}^{-1} D = I_m, \quad (22)$$

the solution vector can be uniquely determined. Where I_m is an identity matrix with order m .

When the right-inverse matrix check DD'_{Appro}^{-1} becomes

$$DD'_{Appro}^{-1} = I_n, \quad (23)$$

The existence of solution vector can be confirmed. Where I_n is an identity matrix with order n .

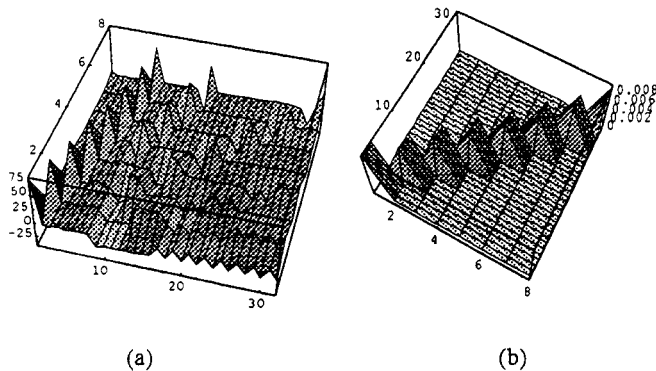


Fig. 2. (a) Two-dimensional wavelet spectrum D' of the system, and (b) an approximate inverse matrix D_{Appro}^{-1} .

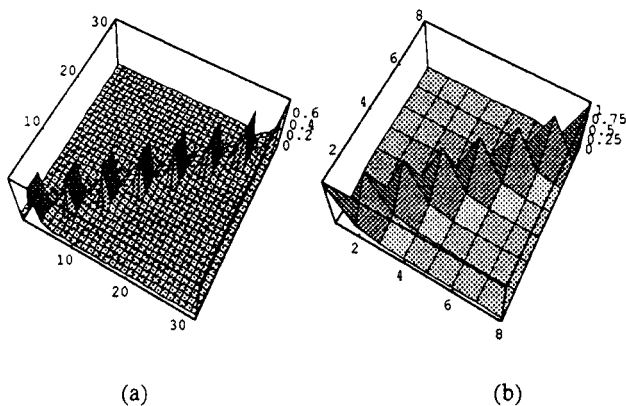


Fig. 3. (a) The left-inverse matrix check $D_{Appro}^{-1} D$ and (b) the right-inverse matrix check DD_{Appro}^{-1} .

Thus, the left-inverse matrix check means the uniqueness of solution. The left-inverse matrix check shown in figure 3(a) is similar to the identity matrix I_m . This means that an approximate solution vector could be expected. Also, the right-inverse matrix check shown in figure 3(b) is the identity matrix I_n . This means that the existence of solution vector could be expected.

E. Wavelet solution

The current vector X in (18a) is given by

$$X = D_{Appro}^{-1} Y. \tag{24}$$

Figures 4(a) and 4(b) show the estimated current distribution on the film conductor and reproduced magnetic fields, respectively.

Thus, we have succeeded in estimating the current distribution from the locally measured magnetic fields.

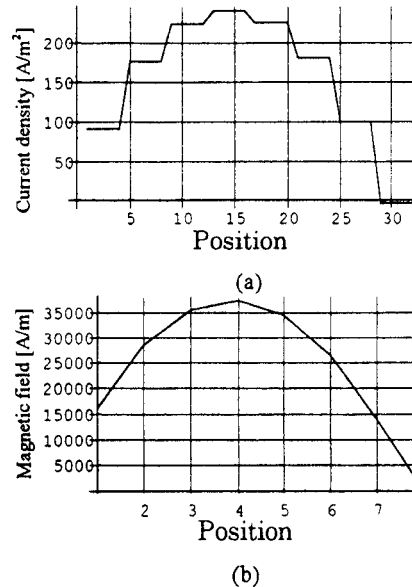


Fig.4. (a) The estimated current distribution on the film conductor, and (b) the reproduced magnetic fields from the estimated currents.

IV. CONCLUSION

In the present article, we have proposed an inverse approach employing the discrete wavelet transform. The two-dimensional wavelet analysis is applied to the rectangular system matrix as an image data. And the approximate inverse matrix of the system is obtained from a square part of the wavelet spectrum. Applying the inverse wavelet transform to the approximate inverse matrix in the wavelet spectrum space yields this approximate inverse matrix in the original space. Further, we have checked up the mathematical validity of the approximate inverse matrix.

The simple example concerning to the current estimation from the locally measured magnetic fields has demonstrated the validity of our approach.

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Wavelet Solution of The Inverse Parameter Problems

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Abstract – Previously, we have proposed a method of solving inverse problems, and successfully applied the method to biomagnetic fields as well as the nondestructive testing in metallic materials. In the present article, we propose a novel inverse approach for the parameter determination problems employing wavelet analysis. A simple example of parameter determination demonstrates the validity of our wavelet approach.

I. INTRODUCTION

Inverse problems are classified into two major categories, i.e. one is the inverse parameter problem; the other is the inverse source problem. For the inverse parameter problem, it is possible to obtain a unique solution if the fields are measured ideally; such as medium parameter identification in human body employing the computed tomography (CT). However, most of the inverse problems are generally reduced to solving a system equation for which it is difficult to obtain a unique solution. In order to overcome this difficulty, we have previously proposed a method of solving the inverse problems, and successfully applied it to biomagnetic fields as well as to nondestructive testing in metallic materials [1,2].

On the other hand, the wavelet analysis has been studied for image data compression and analyzing the spectrum of image in informatics [3-6].

In the present article, we propose a novel approach for the inverse parameter problems employing wavelet analysis. The key idea is that a system matrix of the inverse problems is regarded as two-dimensional image data. The two-dimensional wavelet transform is applied to this system matrix. An approximate inverse matrix of the system is obtained from the wavelet spectrum. We here consider a test example in which the relationship between input and output is evaluated from given input and output data. As a result, the example demonstrates the validity of our wavelet approach.

II. DISCRETE WAVELET TRANSFORM

A. One-dimensional wavelet transform

In the present paper, we employ Haar's analyzing wavelets [3]. Let us consider a following linear transformation

$$X' = CX, \tag{1}$$

where X is a data vector with order n ; n must be a power of 2; and C is

$$C = \begin{bmatrix} c_0 & c_1 & 0 & 0 & \dots & 0 & 0 \\ c_1 & -c_0 & 0 & 0 & \dots & 0 & 0 \\ 0 & 0 & c_0 & c_1 & \dots & 0 & 0 \\ 0 & 0 & c_1 & -c_0 & \dots & 0 & 0 \\ \dots & \dots & \dots & \dots & \dots & \dots & \dots \\ \dots & \dots & \dots & \dots & \dots & \dots & \dots \\ 0 & 0 & 0 & 0 & \dots & c_0 & c_1 \\ 0 & 0 & 0 & 0 & \dots & c_1 & -c_0 \end{bmatrix} \tag{2}$$

In equation (2), the first, third, fifth, and the other odd rows generate the components of data convolved with the coefficients c_0, c_1 . This corresponds to a weighted integral operation. On the other hand, the even rows generate the components of data convolved with the coefficients $c_1, -c_0$. This corresponds to a weighted differential operation [3,5].

In order to carry out an inverse transformation, the coefficients c_0, c_1 should be determined by a relationship:

$$C^T C = I, \tag{3}$$

where I is a n -th order unit matrix and a superscript T refers to the transpose of matrix C .

From equations (2) and (3), we have

$$c_0^2 + c_1^2 = 1 \tag{4}$$

Equation (4) has two unknowns c_0, c_1 , but we have only one equation. To determine the coefficients c_0, c_1 , generally, a following conditions is considered:

$$c_0 - c_1 = 0. \tag{5}$$

From equations (4) and (5), we have

$$c_0 = \frac{1}{\sqrt{2}}, \quad c_1 = \frac{1}{\sqrt{2}}. \tag{6}$$

The pair of coefficient c_0, c_1 in (6) is Haar's analyzing wavelets, which are equivalent to Daubechies's second order

analyzing wavelets [3,4].

For simplicity, let us consider a data vector \mathbf{X} with order 8:

$$\mathbf{X} = [x_1, x_2, x_3, x_4, x_5, x_6, x_7, x_8]^T. \quad (7)$$

Applying the transform matrix C_8 to (7) yields

$$\mathbf{X}' = C_8 \mathbf{X} = [s_1, d_1, s_2, d_2, s_3, d_3, s_4, d_4]^T. \quad (8)$$

The elements in vector \mathbf{X}' are sorted by using the following matrix:

$$P_8 = \begin{bmatrix} 1 & 0 & 0 & 0 & 0 & 0 & 0 & 0 \\ 0 & 0 & 1 & 0 & 0 & 0 & 0 & 0 \\ 0 & 0 & 0 & 0 & 1 & 0 & 0 & 0 \\ 0 & 0 & 0 & 0 & 0 & 0 & 1 & 0 \\ 0 & 1 & 0 & 0 & 0 & 0 & 0 & 0 \\ 0 & 0 & 0 & 1 & 0 & 0 & 0 & 0 \\ 0 & 0 & 0 & 0 & 0 & 1 & 0 & 0 \\ 0 & 0 & 0 & 0 & 0 & 0 & 0 & 1 \end{bmatrix} \quad (9)$$

Thus, we have

$$P_8 \mathbf{X}' = P_8 C_8 \mathbf{X} = [s_1, s_2, s_3, s_4, d_1, d_2, d_3, d_4]^T. \quad (10)$$

Further transformation to the elements s_1, s_2, s_3, s_4 in (10) yields

$$W^8 \mathbf{X} = [S_1, S_2, D_1, D_2, d_1, d_2, d_3, d_4]^T, \quad (11)$$

where

$$W^{(2)} = (P_4' C_4'') \chi (P_4 C_4'), \quad P_4' = \begin{bmatrix} P_4 & 0 \\ 0 & I_4 \end{bmatrix}, \quad C_4' = \begin{bmatrix} C_4 & 0 \\ 0 & I_4 \end{bmatrix}. \quad (12)$$

Similar transformation to S_1, S_2, D_1, D_2 in (11) yields

$$W^8 \mathbf{X} = [S_1, D_1, D_2, d_1, d_2, d_3, d_4]^T. \quad (13)$$

where

$$W^{(3)} = (P_2'' C_2''') \chi (P_2' C_2') \chi (P_2 C_2'), \quad P_2'' = \begin{bmatrix} P_2 & 0 \\ 0 & I_6 \end{bmatrix}, \quad C_2'' = \begin{bmatrix} C_2 & 0 \\ 0 & I_6 \end{bmatrix}. \quad (14)$$

The wavelet transform of one-dimensional data with order 8 is finally given by $3 (= \log_2 8)$ steps of linear transformation. Equation (13) is the finally obtained wavelet spectrum. The elements S_1, D_1 in (13) are called the Mother Wavelet coefficients, and the others are called the wavelet coefficients at each level.

Inverse wavelet transform is carried out by

$$\begin{aligned} \mathbf{X} &= [W^{(3)}]^{-T} (W^{(3)} \mathbf{X}), \\ [W^{(3)}]^{-T} &= [(P_2'' C_2''') \chi (P_2' C_2') \chi (P_2 C_2')]^{-T}, \\ &= (P_2 C_2')^{-T} (P_2' C_2')^{-T} (P_2'' C_2''')^{-T}, \\ &= C_2^{-T} P_2^{-T} (C_2')^{-T} (P_2')^{-T} (C_2'')^{-T} (P_2'')^{-T}. \end{aligned} \quad (15)$$

B. Two-dimensional wavelet transform

The discrete wavelet transform can be extended to two dimensions [3]. Usually, two-dimensional wavelet transform is applied to a square matrix. In this article, two-dimensional wavelet transform is generalized to a rectangular matrix. The generalized two-dimensional wavelet transform is given by

$$M' = W_n M W_m^T, \quad (16)$$

where M' and M are the transformed (spectrum) matrix and original matrix with order n by m , respectively. W_n and W_m are the wavelet transform matrices with order n by n and m by m , respectively.

The inverse wavelet transform is carried out by the following equation:

$$M = W_n^T M' W_m. \quad (17)$$

III. THE INVERSE PARAMETER PROBLEMS

A. Wavelet approach

The key idea is that the system matrix is regarded as one of the image data. The system matrix as an image data is transformed into a space of wavelet spectrum.

Let us consider an inverse parameter problem. The system $\mathbf{X} = \mathbf{C}\mathbf{Y}$ can be modified by exchanging the elements in the vector \mathbf{Y} and matrix \mathbf{C} , viz.

$$\mathbf{X} = \mathbf{Y}\mathbf{C}, \quad (18)$$

where a matrix \mathbf{Y} and vector \mathbf{C} are the system matrix composed of the elements in \mathbf{Y} and parameter vector to be determined, respectively. In order to solve for (18), we apply the two-dimensional discrete wavelet transform to (18). The system matrix \mathbf{Y} is transformed by

$$\mathbf{Y}' = W_n \mathbf{Y} W_m^T. \quad (19)$$

From the result of (19), it is found that the spectrum matrix can be classified into two major groups. One group

takes the large absolute value, and the other takes the smaller absolute value. We take a square matrix S around the Mother wavelet coefficient out of the entire wavelet spectrum Y' . Generally, the square matrix S around the Mother wavelet coefficients have large values. After taking of the inverse matrix of S , we embed this inverse matrix into a zero matrix Z with order m by n .

$$Y'_{Appro}^{-1} = S^{-1} \rightarrow Z. \tag{20}$$

Equation (20) means that the inverse matrix S^{-1} is embedded at the top square region of Z .

The approximate inverse matrix Y'_{Appro}^{-1} of the system is obtained by the two-dimensional inverse wavelet transform:

$$Y_{Appro}^{-1} = W_n^T Y'_{Appro}^{-1} W_m. \tag{21}$$

Finally, the parameter vector of system C is given by

$$C = Y_{Appro}^{-1} X. \tag{22}$$

Thus, the parameter vector C can be obtained from the known input Y and output X .

B. An example

Let us consider an example of parameter identification problems. For this example, the current and magnetic field distribution are known vectors, but the relationship between them is unknown. This example is reduced to solving for the following system equation

$$X = YC, \tag{23a}$$

or

$$\begin{bmatrix} x_1 \\ x_2 \\ \vdots \\ x_n \end{bmatrix} = \begin{bmatrix} y_1 & \cdots & y_n & 0 & \cdot & \cdot & \cdot & \cdot & 0 \\ 0 & \cdots & 0 & y_1 & \cdots & y_n & 0 & \cdots & 0 \\ \cdot & \cdot & \cdot & \cdot & \cdot & \cdot & \cdot & \cdot & \cdot \\ 0 & \cdot & \cdot & \cdot & \cdot & 0 & y_1 & \cdots & y_n \end{bmatrix} \begin{bmatrix} c_{11} \\ c_{12} \\ c_{13} \\ \vdots \\ c_m \end{bmatrix}, \tag{23b}$$

where C, X and Y are a vector of system parameter to be determined, an output vector, and the system matrix composed of the input current, respectively.

Figure 1 shows an example of a parameter identification problem from both input currents and output magnetic field vectors. Actually, exact parameter of the vector C in (23b) are determined by the Ampere's law. We verify that the exact parameter can be identified by the wavelet approach.

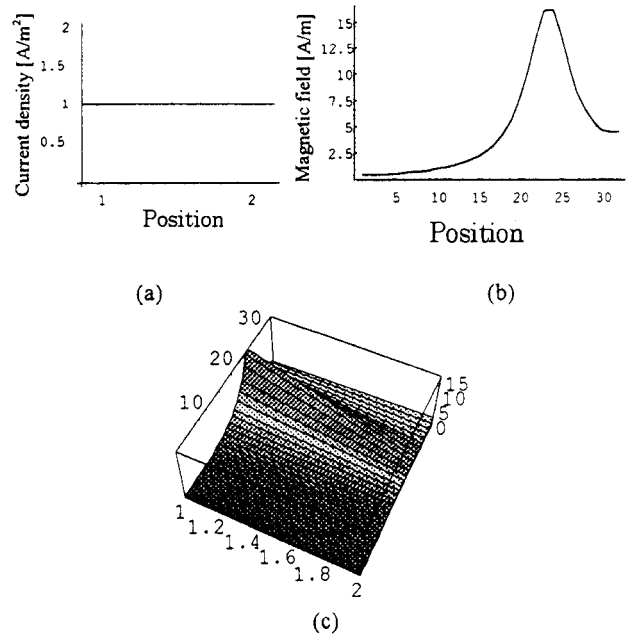


Fig.1. (a) An input current vector Y , (b) an output magnetic field vector X , and (c) the system matrix.

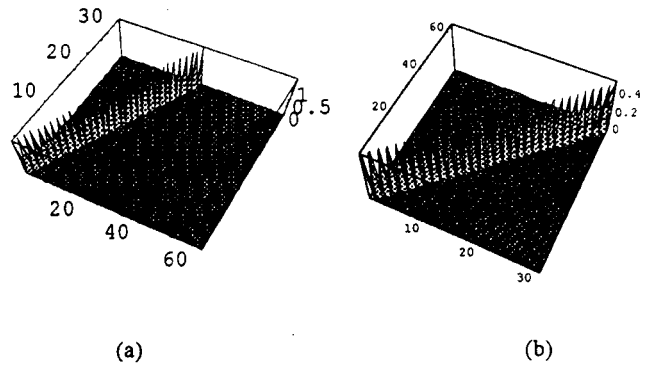


Fig. 2. (a) Two-dimensional wavelet spectrum Y' of the system, and (b) an approximate inverse matrix Y'_{Appro}^{-1} .

Figures 1(a), 1(b) and 1(c) show an input current distribution, an output magnetic field distribution, and the system matrix of this parameter identification problem in (23b), respectively.

Figures 2(a) and 2(b) show a two-dimensional wavelet spectrum Y' of the system in figure 1(c) and an approximate inverse matrix Y'_{Appro}^{-1} of the system, respectively.

Finally, the parameter vector C in (23) is given by

$$C = Y_{Appro}^{-1} X. \tag{24}$$

Figures 3(a) and 3(b) show the determined parameter of the system, and reproduced magnetic field distribution, respectively. The result in 3(a) coincides with those of the Ampere's law. Actually, the parameter of the system is determined by the Ampere's law. Thus, we have succeeded

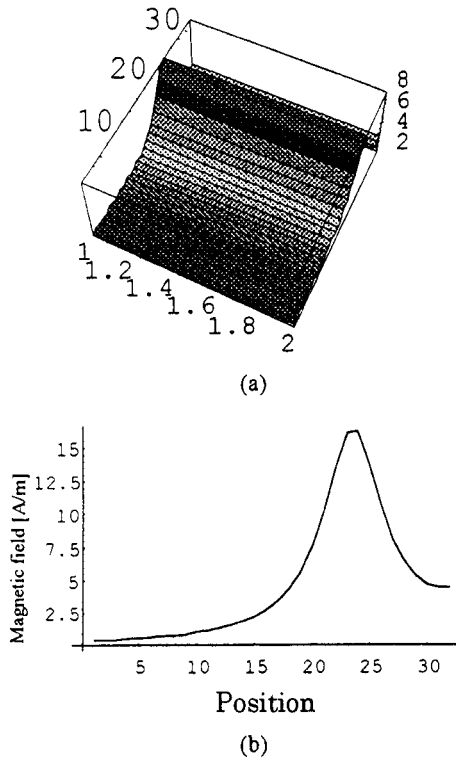


Fig.3. (a) The decided system matrix, and (b) the reproduced magnetic field distribution by the estimation system matrix.

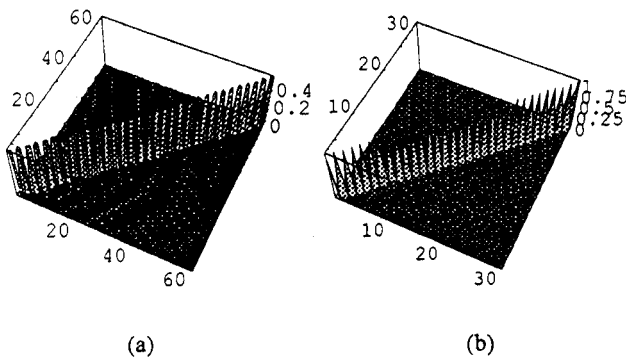


Fig.4. (a) The left-inverse matrix check $Y_{Appro}^{-1} Y$ and (b) the right-inverse matrix check $Y Y_{Appro}^{-1}$.

in estimating the parameter of the system from both the input and output vectors.

C. Validity of the approximate inverse matrix

Mathematical validity of the inverse matrix is generally carried out by means of the left- and right-inverse matrix checks. In this inverse parameter problem, the left-inverse matrix check $Y_{Appro}^{-1} Y$ is not equivalent to the right-inverse matrix check $Y Y_{Appro}^{-1}$, because the system matrix is

rectangular. When the left-inverse matrix check $Y_{Appro}^{-1} Y$ becomes

$$Y_{Appro}^{-1} Y = I_m, \tag{25}$$

the solution vector can be uniquely determined, where I_m is an identity matrix with order m .

When the right-inverse matrix check $Y Y_{Appro}^{-1}$ becomes

$$Y Y_{Appro}^{-1} = I_n, \tag{26}$$

the existence of solution vector can be confirmed, where I_n is an identity matrix with order n .

Thus, the left-inverse matrix check means the uniqueness of solution. The left-inverse matrix check shown in figure 4(a) is similar to the identity matrix I_m . This means that an approximate solution vector could be expected. Also, the right-inverse matrix check shown in figure 4(b) is the identity matrix I_n . This means that the existence of solution vector could be expected.

IV. CONCLUSION

In the present paper, we have proposed a novel approach for the inverse parameter problems employing the wavelet analysis. The wavelet analysis is applied to the system matrix of the inverse parameter problems. The results reveal that our wavelet approach is possible to get an approximate inverse matrix of the system. A simple example has demonstrated the validity of our approach.

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